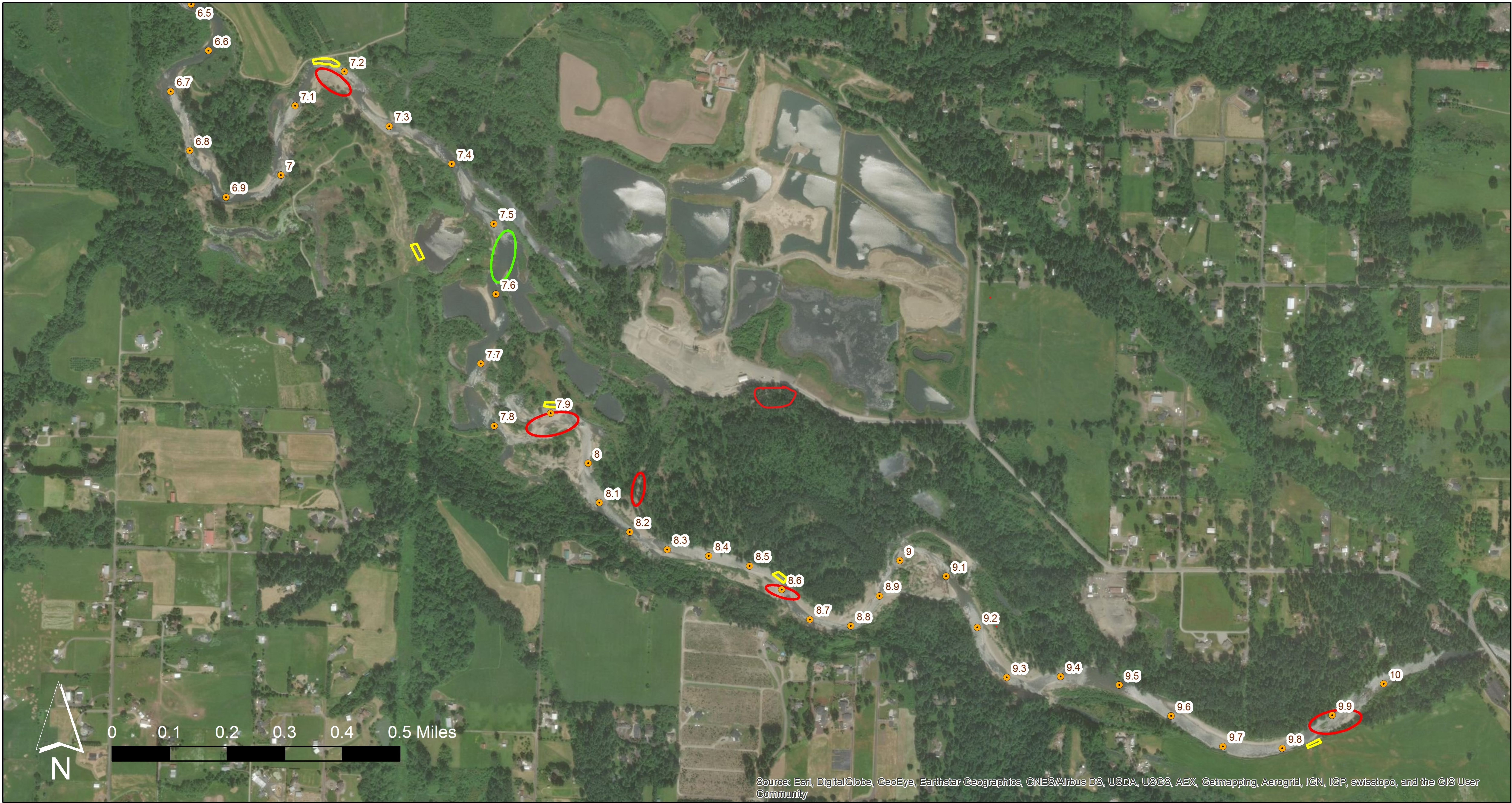




EF Lewis Ridgefield Pits Sediment Sampling Plan

Created Oct 2018

- Type**
- Surface and subsurface pebble counts
 - Bank cut profile (descriptive)
 - Surface characterization and depth of refusal

Surface samples to be collected using pebble counts on transects across the active channel. Subsurface counts to be done by removing the surface layer at a representative sampling location and performing pebble counts on the subsurface material as described in Buffington (1996) as cited and described in Bunte and Abt (2001).